

OptiMOS™ P3 Small-Signal-Transistor

Features

- P-channel
- Enhancement mode
- Logic level (4.5V rated)
- ESD protected
- Qualified according to AEC Q101
- 100% lead-free; RoHS compliant
- Halogen-free according to IEC61249-2-21



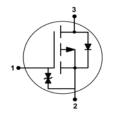




Product Summary

V _{DS}	-30	V	
$R_{\rm DS(on),max}$ $V_{\rm GS}$ =-10 V		80	mΩ
	V _{GS} =-4.5 V	130	
I _D	-2.0	Α	







Туре	Package	Tape and Reel Information	Marking	Lead Free	Packing
BSS308PE	PG-SOT23	H6327: 3000 pcs/ reel	YFs	Yes	Non dry

Maximum ratings, at T_j =25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current	ID	T _A =25 °C	-2.0	Α
		T _A =70 °C	-1.6	
Pulsed drain current	I _{D,pulse}	T _A =25 °C	-8.0	
Avalanche energy, single pulse	E _{AS}	$I_{\rm D}$ =-2 A, $R_{\rm GS}$ =25 Ω	-10.7	mJ
Reverse diode dv/dt	dv/dt	I_D =-2 A, V_{DS} =-16V, di/dt =-200A/ μ s, $T_{j,max}$ =150 °C	6	kV/μs
Gate source voltage	V_{GS}		±20	V
Power dissipation ¹⁾	P _{tot}	T _A =25 °C	0.5	W
Operating and storage temperature	$T_{\rm j},T_{\rm stg}$		-55 150	°C
ESD Class		JESD22-A114 -HBM	2 (2kV to 4kV)	
Soldering Temperature			260 °C	°C
IEC climatic category; DIN IEC 68-1			55/150/56	°C



Parameter	Symbol Conditions	Conditions	Values			Unit
			min.	typ.	max.	
Thermal characteristics						
Thermal resistance, junction - ambient	$R_{ m thJA}$	minimal footprint ¹⁾	-	-	250	K/W

Electrical characteristics, at $T_{\rm j}$ =25 °C, unless otherwise specified

Static characteristics

Drain-source breakdown voltage	V _{(BR)DSS}	V _{GS} = 0V, I _D =-250μA	-30	-	-	V
Gate threshold voltage	$V_{\rm GS(th)}$	$V_{\rm DS}=V_{\rm GS}$, $I_{\rm D}=-11\mu{\rm A}$	-2.0	-1.5	-1.0	
Drain-source leakage current	I _{DSS}	$V_{\rm DS}$ =-30V, $V_{\rm GS}$ =0 V, $T_{\rm j}$ =25 °C	1	ı	-1	μА
		$V_{\rm DS}$ =-30V, $V_{\rm GS}$ =0V, $T_{\rm j}$ =150 °C	ı	ı	-100	
Gate-source leakage current	I _{GSS}	V _{GS} =-20V, V _{DS} =0V	-	1	-5	μΑ
Drain-source on-state resistance	$R_{\mathrm{DS(on)}}$	V _{GS} =-4.5 V, I _D =-1.7 A	1	88	130	mΩ
		V _{GS} =-10 V, I _D =-2 A	ı	62	80	
Transconductance	$g_{ ext{fs}}$	$ V_{\rm DS} > 2 I_{\rm D} R_{\rm DS(on)max},$ $I_{\rm D} = -1.6 \text{ A}$		4.6	1	s

 $^{^{1)}}$ Performed on 40mm^2 FR4 PCB. The traces are 1mm wide, $70\mu\text{m}$ thick and 20mm long; they are present on both sides of the PCB.



Parameter	Symbol	mbol Conditions		Values		Unit
			min.	typ.	max.	
Dynamic characteristics						
Input capacitance	Ciss		-	376	500	pF
Output capacitance	Coss	V _{GS} =0 V, V _{DS} =-15 V, f=1 MHz	-	196	261	
Reverse transfer capacitance	C _{rss}		-	12	18	
Turn-on delay time	$t_{d(on)}$		-	5.6	-	ns
Rise time	t _r	V _{DD} =-15V, V _{GS} =-10 V,	-	7.7	-	
Turn-off delay time	$t_{d(off)}$	$I_{\rm D}$ =-2 A, $R_{\rm G}$ =6 Ω	-	15.3	-	
Fall time	t_{f}]	-	2.8	-	
Gate Charge Characteristics						
Gate to source charge	Q _{gs}		-	-1.2	-	nC
Gate to drain charge	Q_{gd}	$V_{\rm DD}$ =-15 V, $I_{\rm D}$ =-2 A, $V_{\rm GS}$ =0 to -10 V	-	-0.6	-	
Gate charge total	Qg		-	-5.0	-	
Gate plateau voltage	V _{plateau}		-	-3.1	-	V
Reverse Diode						
Diode continous forward current	Is	T -25 °C	-	-	-0.4	Α
Diode pulse current	I _{S,pulse}	- T _A =25 °C	-	-	-8.4	7
Diode forward voltage	V _{SD}	V _{GS} =0 V, I _F =-2 A, T _j =25 °C	-	-0.8	-1.1	V
Reverse recovery time	t _{rr}	V_R =10 V, I_F =-2 A, di_F/dt =100 A/ μ s	-	14	-	ns
Reverse recovery charge	Q _{rr}		-	-5.9	-	nC

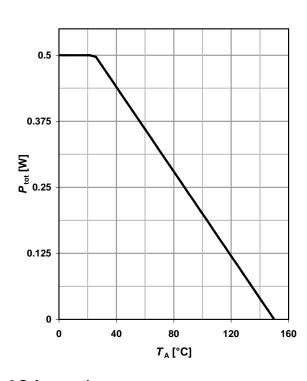


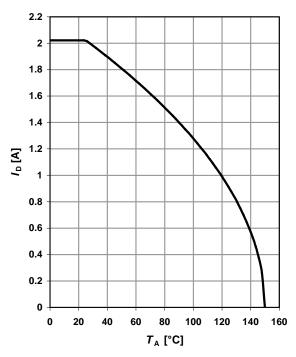
1 Power dissipation

P_{tot} =f(T_A)

2 Drain current

$$I_D = f(T_A); V_{GS} \ge 10 \text{ V}$$

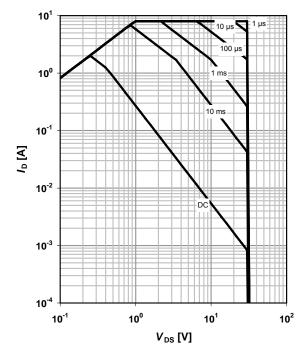




3 Safe operating area

$$I_{\rm D}$$
=f($V_{\rm DS}$); $T_{\rm A}$ =25 °C; D =0

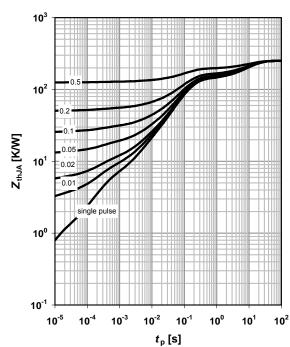
parameter: $t_{\rm p}$



4 Max. transient thermal impedance

$$Z_{\text{thJA}}$$
=f(t_{p})

parameter: $D=t_p/T$

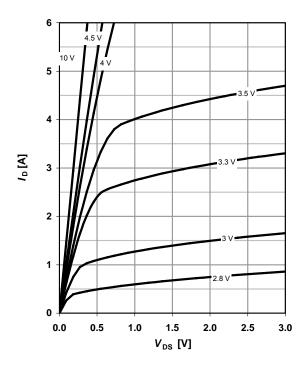




5 Typ. output characteristics

 I_D =f(V_{DS}); T_j =25 °C

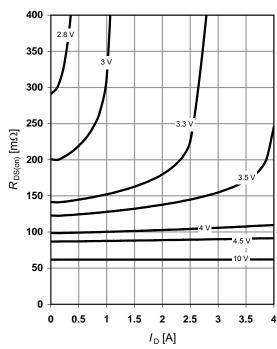
parameter: V_{GS}



6 Typ. drain-source on resistance

 $R_{DS(on)}$ =f(I_D); T_j =25 °C

parameter: V_{GS}

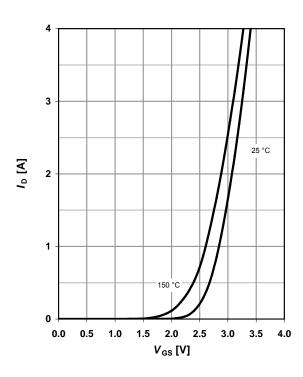


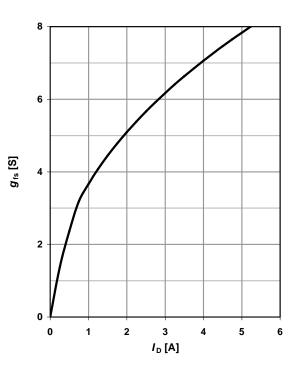
7 Typ. transfer characteristics

 I_{D} =f(V_{GS}); $|V_{DS}|$ >2 $|I_{D}|R_{DS(on)max}$

8 Typ. forward transconductance

$$g_{fs}$$
=f(I_D); T_j =25 °C

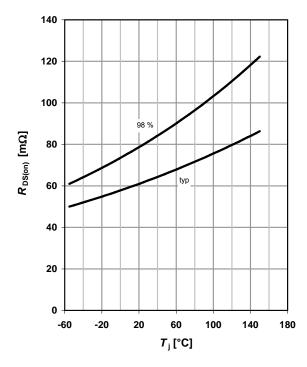






9 Drain-source on-state resistance

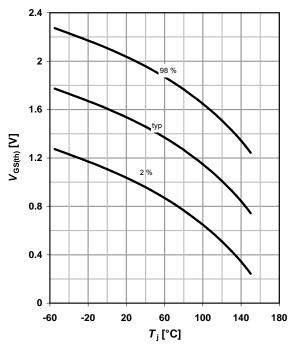
$$R_{DS(on)}$$
=f(T_j); I_D =-2 A; V_{GS} =-10 V



10 Typ. gate threshold voltage

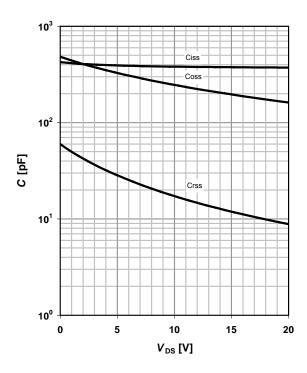
$$V_{GS(th)}$$
=f(T_j); V_{DS} = V_{GS} ; I_D =11 μ A

parameter: I_D



11 Typ. capacitances

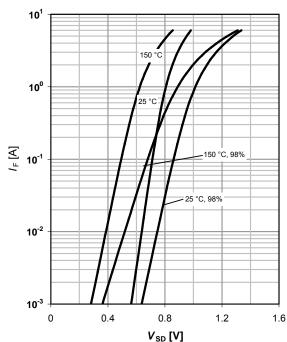
 $C=f(V_{DS}); V_{GS}=0 V; f=1 MHz; T_j=25$ °C



12 Forward characteristics of reverse diode

$$I_{\mathsf{F}} = \mathsf{f}(V_{\mathsf{SD}})$$

parameter: $T_{\rm j}$





13 Avalanche characteristics

 I_{AS} =f(t_{AV}); R_{GS} =25 Ω

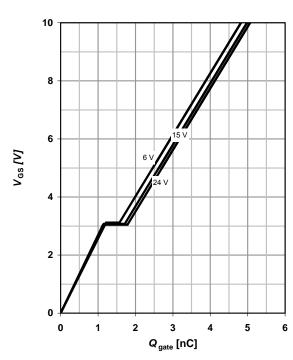
parameter: $T_{j(start)}$

10¹ 10⁰ 10¹ 10¹ 10¹ 10² 10³ t_{AV} [µs]

14 Typ. gate charge

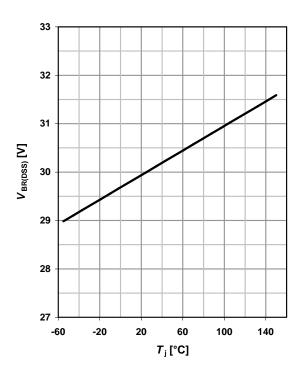
 $V_{\rm GS}$ =f(Q_{gate}); $I_{\rm D}$ =-2 A pulsed

parameter: $V_{\rm DD}$

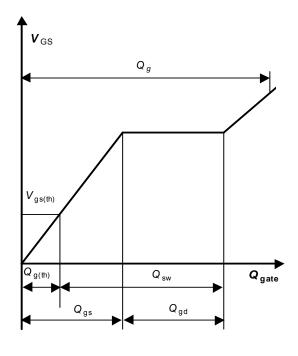


15 Drain-source breakdown voltage

 $V_{BR(DSS)}$ =f(T_i); I_D =250 μ A



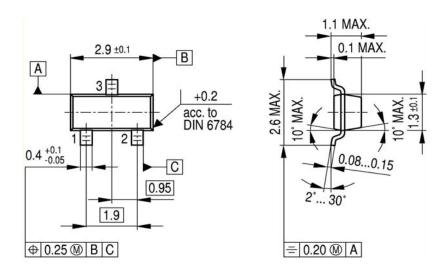
16 Gate charge waveforms





SOT-23

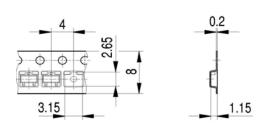
Package Outline:



Footprint:

0.9

Packaging:





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